

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10673631	HWANG, YONG SUK
	Examiner	Art Unit
	Lee, Siu M	2611

SEARCHED

Class	Subclass	Date	Examiner
375	326, 150, 316, 371, 354, 373, 375, 376	12/07/2006	Siu M. Lee

SEARCH NOTES

Search Notes	Date	Examiner
US-PGPUB	12/07/2006	Siu M. Lee
USPAT	12/07/2006	Siu M. Lee
USOCR	12/07/2006	Siu M. Lee
EPO	12/07/2006	Siu M. Lee
JPO	12/07/2006	Siu M. Lee
Derwent	12/07/2006	Siu M. Lee
IBM_TDB	12/07/2006	Siu M. Lee
Discussed the application with Chieh Fan	12/07/2006	Siu M. Lee

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner